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March 2015

FDD6030L

30V N-Channel PowerTrench® MOSFET

General Description

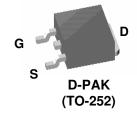
This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on state resistance and yet maintain low gate charge for superior switching performance.

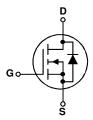
Applications

- DC/DC converter
- Motor Drives

Features

- 12 A, 30 V $R_{DS(ON)} = 14.5 \ m\Omega \ @V_{GS} = 10 \ V$ $R_{DS(ON)} = 21 \ m\Omega \ @V_{GS} = 4.5 \ V$
- · Low gate charge
- Fast Switching Speed
- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Pa	rameter		Ratings	Units	
V _{DSS}	Drain-Source Voltage			30	V	
V _{GSS}	Gate-Source Voltage			±20	V	
I _D	Continuous Drain Current @T _C =25°C (Note 3)		(Note 3)	50	А	
		@T _A =25°C	(Note 1a)	12		
		Pulsed	(Note 1a)	100		
P _D	Power Dissipation	@T _C =25°C	(Note 3)	56	W	
		@T _A =25°C	(Note 1a)	3.2		
		@T _A =25°C	(Note 1b)	1.5		
T_J, T_{STG}	Operating and Storage Junction Temperature Range			-55 to +175	°C	

Thermal Characteristics

R _{eJC}	Thermal Resistance, Junction-to-Case	(Note 1)	2.7	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	45	
$R_{\theta JA}$		(Note 1b)	96	

Package Marking and Ordering Information

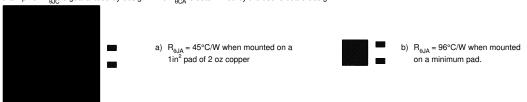
Device Marking	Device	Package	Reel Size	Tape width	Quantity
FDD6030L	FDD6030L	D-PAK (TO-252)	13"	16mm	2500 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Syllibol	Parameter	rest Conditions	IVIIII	тур	IVIAX	Ullit
Drain-So	urce Avalanche Ratings (Note	2)				
E _{AS}	Drain-Source Avalanche Energy	Single Pulse, $V_{DD} = 15 \text{ V}$, $I_{D} = 12 \text{A}$			100	mJ
I _{AS}	Drain-Source Avalanche Current				12	Α
Off Chara	acteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = 250 \mu\text{A}$	30			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A,Referenced to 25°C		24		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, \qquad V_{GS} = 0 \text{ V}$			1	μΑ
I _{GSS}	Gate-Body Leakage	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA
On Chara	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	1	1.9	3	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 μ A,Referenced to 25°C		- 5		mV/°(
R _{DS(on)}	Static Drain–Source On–Resistance	$V_{GS} = 10 \text{ V}, I_D = 12 \text{ A} $ $V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A} $ $V_{GS} = 10 \text{ V}, I_D = 12 \text{ A}, T_J = 125^{\circ}\text{C}$		7.7 9.9 11.4	14.5 21 25	mΩ
I _{D(on)}	On-State Drain Current	$V_{GS} = 10 \text{ V}, \qquad V_{DS} = 5 \text{ V}$	50			Α
g _{FS}	Forward Transconductance	$V_{DS} = 10 \text{ V}, \qquad I_{D} = 12 \text{ A}$		47		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance			1230		pF
C _{oss}	Output Capacitance	$V_{DS} = 15 \text{ V}, \qquad V_{GS} = 0 \text{ V},$ $f = 1.0 \text{ MHz}$		325		pF
C _{rss}	Reverse Transfer Capacitance			150		pF
R _G	Gate Resistance	V _{GS} = 15 mV, f = 1.0 MHz		1.5		pF
Switchin	g Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time			10	19	ns
t _r	Turn-On Rise Time	$V_{DD} = 15 \text{ V}, \qquad I_{D} = 1 \text{ A}, \\ V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$		7	13	ns
t _{d(off)}	Turn-Off Delay Time			29	46	ns
t _f	Turn-Off Fall Time]		12	21	ns
Qg	Total Gate Charge			13	28	nC
Q _{gs}	Gate-Source Charge	$V_{DS} = 15V$, $I_{D} = 12 A$, $V_{GS} = 5 V$		3.5		nC
Q _{qd}	Gate-Drain Charge	*G5 - C *		5.1		nC

Electrical Characteristics T _A = 25°C unless otherwise noted								
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units		
Drain-Source Diode Characteristics and Maximum Ratings								
Is	Maximum Continuous Drain-Source Diode Forward Current				2.7	Α		
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 2.7 \text{ A}$ (Note 2)		0.76	1.2	V		
t _{rr}	Diode Reverse Recovery Time	$I_F = 12 \text{ A}, \qquad d_{iF}/d_t = 100 \text{ A}/\mu\text{s}$		24		nS		
Q _{rr}	Diode Reverse Recovery Charge]		13		nC		

Notes:

 R_{aJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{aJC} is guaranteed by design while R_{eCA} is determined by the user's board design.



Scale 1:1 on letter size paper

- 2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%
- 3. Maximum current is calculated as: $\sqrt{\frac{P_D}{R_{DS(ON)}}}$

where P_D is maximum power dissipation at $T_C = 25^{\circ}C$ and $R_{DS(on)}$ is at $T_{J(max)}$ and $V_{GS} = 10V$. Package current limitation is 21A

Typical Characteristics

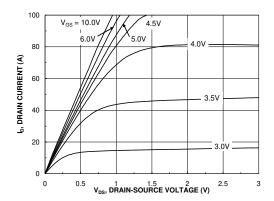


Figure 1. On-Region Characteristics

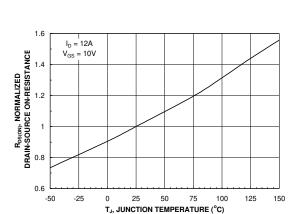


Figure 3. On-Resistance Variation withTemperature

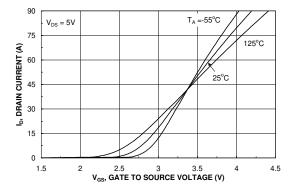


Figure 5. Transfer Characteristics

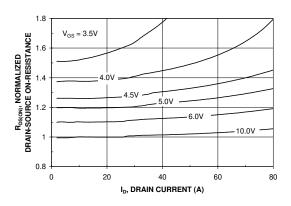


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage

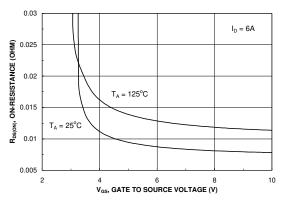


Figure 4. On-Resistance Variation with Gate-to-Source Voltage

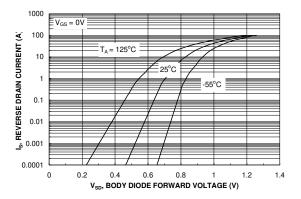
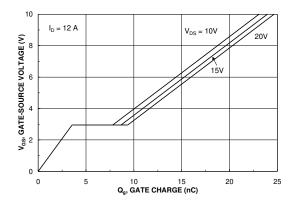


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature

Typical Characteristics



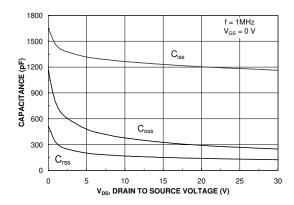
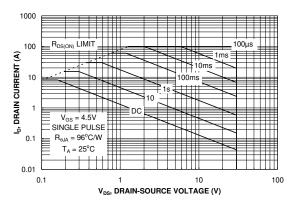


Figure 7. Gate Charge Characteristics





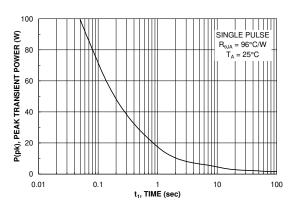


Figure 9. Maximum Safe Operating Area

Figure 10. Single Pulse Maximum Power Dissipation

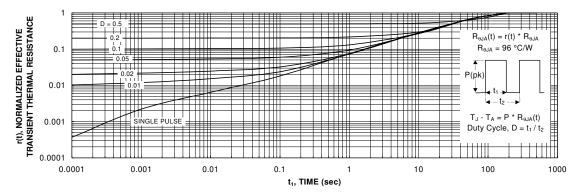
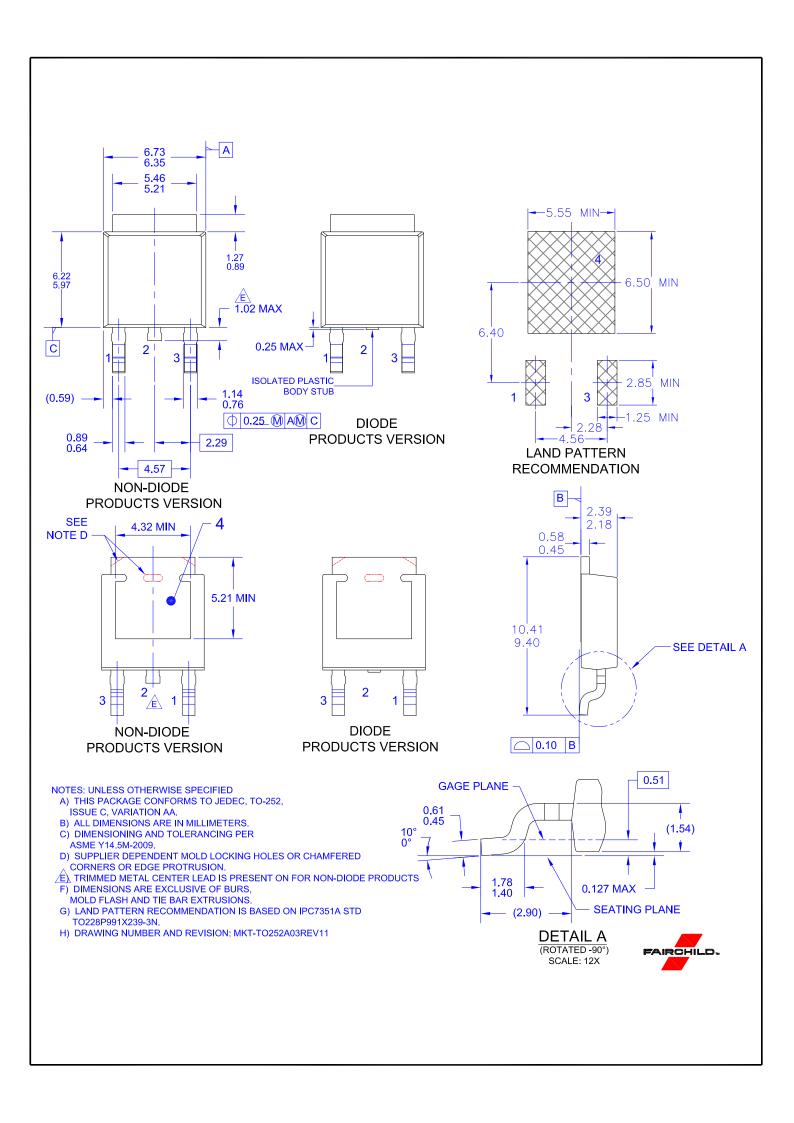


Figure 11. Transient Thermal Response Curve

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.



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